

**Notice of References Cited**

Application/Control No.

10/829,571

Applicant(s)/Patent Under  
Reexamination  
CHEN ET AL.

Examiner

Suman Debnath

Art Unit

2135

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,891,952 B1	05-2005	Puehlhoefer et al.	380/262
*	B	US-5,940,002 A	08-1999	Finn et al.	340/5.26
*	C	US-5,293,576 A	03-1994	Mihm et al.	713/170
*	D	US-7,009,940 B2	03-2006	Vialen et al.	370/252
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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